Searcn Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/670,876	CHEN ET AL.	
Examiner	Art Unit	
lim Vannucci	2828	

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
active layer, mesa, ridge waveguide, 372/107	9/8/2005	JV
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